FQD12P10TM_F085 P-Channel MOSFET FAIRCHILD SEMICONDUCTOR® February 2010 FQD12P10TM_F085 **100V P-Channel MOSFET General Description Features** These P-Channel enhancement mode power field effect -9.4A, -100V, R_{DS(on)} = 0.29Ω @V_{GS} = -10 V transistors are produced using Fairchild's proprietary, • Low gate charge (typical 21 nC) planar stripe, DMOS technology. • Low Crss (typical 65 pF) This advanced technology has been especially tailored to Fast switching minimize on-state resistance, provide superior switching • 100% avalanche tested performance, and withstand high energy pulse in the Improved dv/dt capability avalanche and commutation mode. These devices are well • Qualified to AEC Q101 suited for low voltage applications such as audio amplifier, RoHS Compliant high efficiency switching DC/DC converters, and DC motor control. D D \cap D-PAK Absolute Maximum Ratings T_C = 25°C unless otherwise noted

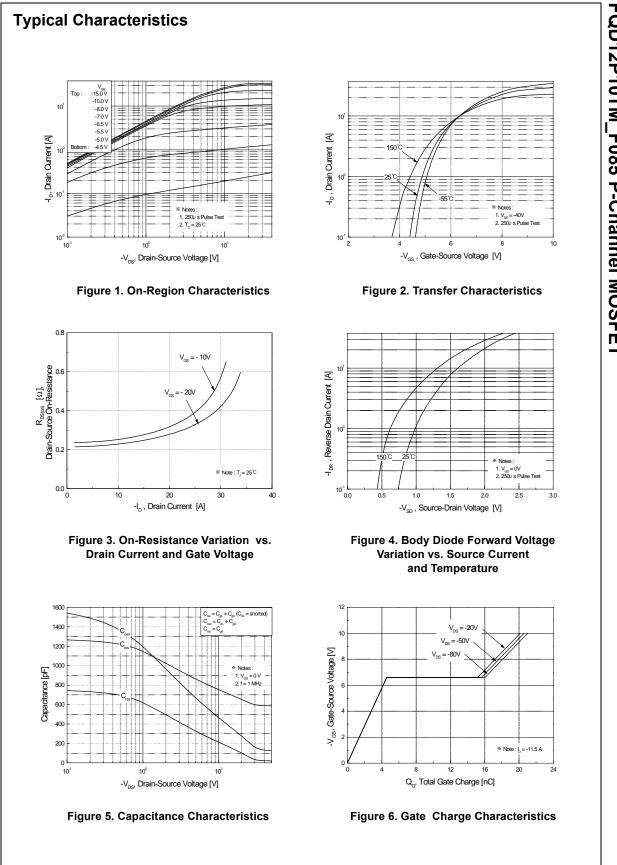
Symbol	Parameter		Rati	ngs	Units
V _{DSS}	Drain-Source Voltage		-100		V
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		-9.4		А
			-6	.0	А
I _{DM}	Drain Current - Pulsed	(Note 1)	-37	7.6	А
V _{GSS}	Gate-Source Voltage		± 30		V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		370		mJ
I _{AR}	Avalanche Current (Note 1)		-9.4		Α
E _{AR}	Repetitive Avalanche Energy (Note 1)		5.0		mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		-6.0		V/ns
PD	Power Dissipation ($T_A = 25^{\circ}C$) *		2.	.5	W
	Power Dissipation (T _C = 25°C)		5	0	W
	- Derate above 25°C		0.4		W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150		°C
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300		°C
Thermal	Characteristics				
Symbol	Baramotor		Tup	Max	Unite

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case 2.5		°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W
$R_{\theta JA}$	JA Thermal Resistance, Junction-to-Ambient 110 °C			
* When mounted	on the minimum pad size recommended (PCB Mount)			

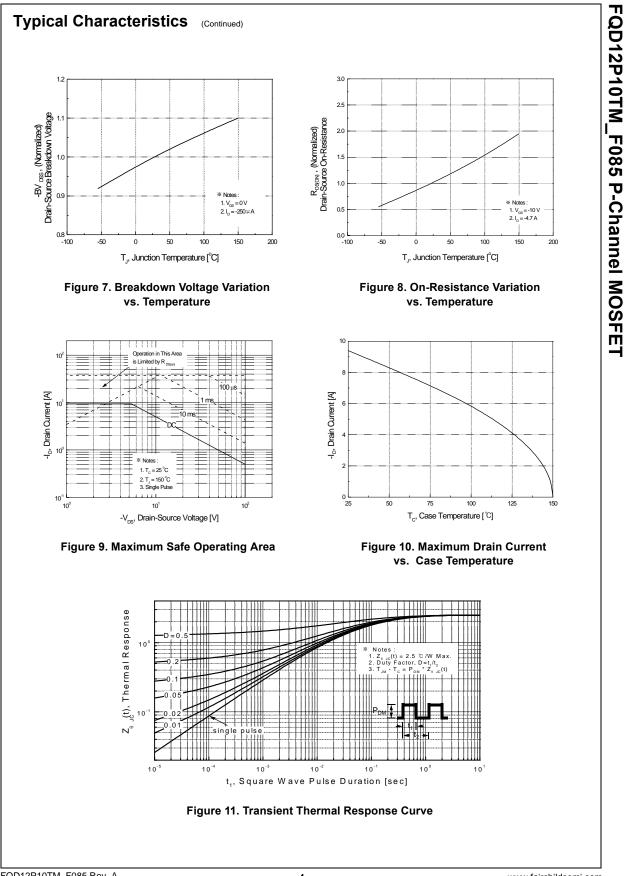
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BV _{DSS} [ΔBV _{DSS} [΄ ΔT _J (acteristics Drain-Source Breakdown Voltage Breakdown Voltage Temperature					
BV _{DSS} [ΔBV _{DSS} [/ ΔT _J (Drain-Source Breakdown Voltage	N 0.1/1 050 A				
ΔT _J (Breakdown Voltage Temperature	V _{GS} = 0 V, I _D = -250 μA	-100			V
DSS -	Coefficient	$I_D = -250 \ \mu\text{A}$, Referenced to 25°C		-0.1		V/°C
		V _{DS} = -100 V, V _{GS} = 0 V			-1	μA
-	Zero Gate Voltage Drain Current	$V_{DS} = -80 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$			-10	μΑ
GSSF (Gate-Body Leakage Current, Forward	$V_{GS} = -30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			-100	nA
GSSR (Gate-Body Leakage Current, Reverse	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
On Chara	acteristics					
	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = -250 μA	-2.0		-4.0	V
R _{DS(on)} S	Static Drain-Source On-Resistance	$V_{GS} = -10 \text{ V}, \text{ I}_{D} = -4.7 \text{ A}$		0.24	0.29	Ω
9 _{FS} F	Forward Transconductance	$V_{DS} = -40 \text{ V}, I_D = -4.7 \text{ A}$ (Note 4)		6.3		S
	•••••		1			1
-	Characteristics					_
	nput Capacitance	$V_{DS} = -25 V, V_{GS} = 0 V,$		620	800	pF
	Output Capacitance Reverse Transfer Capacitance	f = 1.0 MHz		220 65	290 85	pF pF
	g Characteristics				T	
t _{d(on)} 1	Turn-On Delay Time	V _{DD} = -50 V, I _D = -11.5 A,		15	40	ns
t _r 1	Turn-On Rise Time	$R_G = 25 \Omega$		160	330	ns
u(0.1.)	Turn-Off Delay Time	(Note 4, 5)		35	80	ns
	Turn-Off Fall Time			60	130	ns
3	Total Gate Charge	V _{DS} = -80 V, I _D = -11.5 A,		21	27	nC
3-	Gate-Source Charge	V _{GS} = -10 V (Note 4, 5)		4.6		nC
Q _{gd} (Gate-Drain Charge	(1006 4, 3)		11.5		nC
Drain-So	urce Diode Characteristics ar	nd Maximum Ratings			i	
0	Maximum Continuous Drain-Source Dio				-9.4	A
	Maximum Pulsed Drain-Source Diode F				-37.6	A
	Drain-Source Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = -9.4 A$			-4.0	V
	Reverse Recovery Time	$V_{GS} = 0 V, I_S = -11.5 A,$ dlr / dt = 100 A/us (Note 4)		110		ns
Q _{rr} F	Reverse Recovery Charge	$dI_F / dt = 100 \text{ A/}\mu\text{s}$ (Note 4)		0.47		μC
L = 6.3mH, I_{AS} $I_{SD} \leq -11.5A$, c Pulse Test : Pu	ng : Pulse width limited by maximum junction temper = -9.4A, V _{DD} = -25V, R _G = 25 Ω , Starting T _J = 25°C di/dt \leq 300A/µs, V _{DD} \leq BV _{DSS} , Starting T _J = 25°C lse width \leq 300µs, Duty cycle \leq 2% apendent of operating temperature					

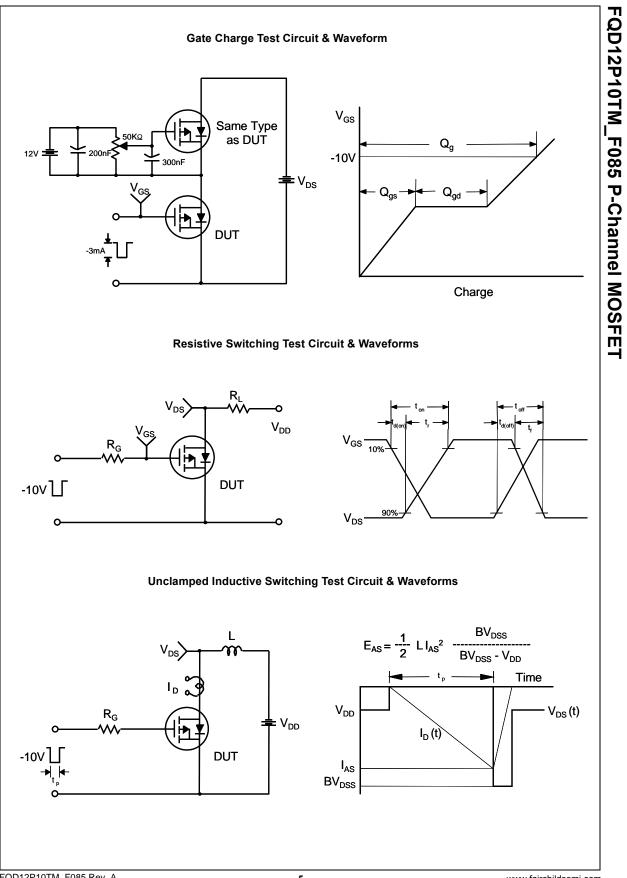


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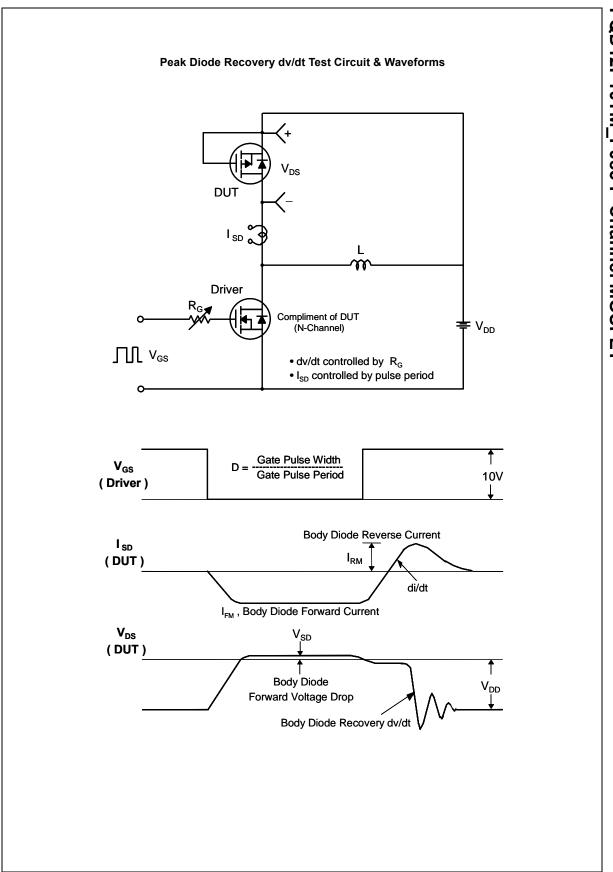


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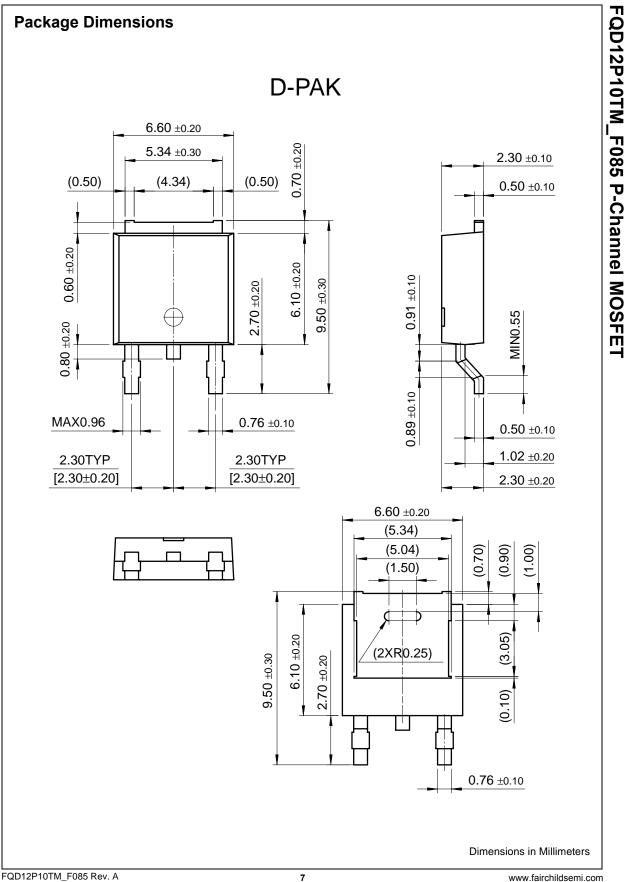
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